Probes FGAB1.3-Fe / D-F-Fe

Data Sheet



Probe model	FGAB1.3-Fe	D-F-Fe		
Part no. ¹	604-264	1007044		
Measurement task	Determination of delta ferrite or alpha martensite			
Applications	Measurement of the delta ferrite content in austenitic and duplex steel. All magnetic components of the otherwise non-magnetic structure are also recognized, that is, in addition to delta ferrite also, e.g., deformation martensite and other ferritic phases. Using the hand-held instrument FERITSCOPE [®] FMP30 you can measure both the delta ferrite content and the alpha martensite content.			
Examples	Measurements according to the Basler Standard			
	Inspection of the ferrite	Inspection of the ferrite content in weld seams and austenitic platings		
	Measurement of the ferrite content or martensite content (only connected with hand-held instrume FERITSCOPE [®] FMP30) to estimate the material properties as the susceptibility to cracking under ten vibration, material strength or toughness, corrosion resistance			
Feature	well suited for small measuring areas due to the small probe diameter			
Measuring range	0.1 120 FN or 0.1 80 Fe% (You can select between the units WR-FN and Fe% in all connectable instruments. In the hand-held instrument FERITSCOPE [®] FMP30 you can additionally select between the units Fe% and α M%)			
*	The specifications for trueness) and repeatability precision apply to ambient and specimen temperatures at the time of calibration. The values for trueness and repeatability may increase compared to the values specified here if the temperature during measurement differs from the temperature during calibration.			
Trueness*				
based on Fischer factory calibration standards at 20 °C (68 °F) for spec- imen and ambient temperature	0.1 5 FN: ≤ 0.15 FN 5 120 FN: ≤ 3 % of nom	ninal value		
Repeatability precision*			Note	
based on Fischer factory calibration standards,at 20 °C (68 °F) for speci- men and ambient temperature 5 single readings per standard	0.1 10 FN: ≤ 0.05 FN 10 40 FN: ≤ 0.5 % of r 40 120 FN: ≤ 1 % of rea	reading ading	The inhomogeneity of the material structure mainly defines the measurement variation. So, the measurement variation is higher for specimen with a larger inhomoge- neity in the material structure as opposed to the factory calibration standards.	
Influence*				
The following values are valid	for ferrite content with a non	ninal value of 10 FN at 20 °	C (68 °F) for specimen and ambient temperature.	
Curvature (R), measurement deviation from nominal value with reference to a calibration on flat surface				
Measuring spot	Measurement deviation \ge 5 % for R \le 10 mm (R \le 0.39 ") Probe needs a minimum of R = 15 mm (support stand necessary) (R = 0.59 ")			
Curvature (R), measurement	deviation from nominal valu	e with reference to a calib	ration on flat surface	
Measuring spot	Measurement deviation \ge 5 % for R \le 5 mm (R \le 0.2 ") Probe needs a minimum of R = 1 mm (support stand necessary) (R = 0.039 ")			
Edge distance (R), specification from probe tip center, measurement deviation from nominal value				
Measuring spot in the center of the circular surface	Measurement deviation ≥ 2 % for R ≤ 3 mm (R ≤ 0.12 ") Probe needs a minimum of R = 5 mm (support stand necessary) (R = 0.2 ")			

Sonden FGAB1.3-Fe / D-F-Fe

Influence*					
The following values are valid f	for ferrite content with a nominal value of 10 FN at 20 °C (68 °F) for specir	nen and ambient temperature.			
Edge distance (X), specificatio	n from probe tip center, measurement deviation from nominal value				
Measuring spot =	Measurement deviation \ge 2 % for X \le 3 mm (X \le 0.12 ")				
Material thickness (D), measu	rement deviation from nominal value				
Measuring spot	Metal sheet thickness D: Measurement deviation ≥ 10 % for D ≤ 1 mm (D ≤ 0.039 ") Plating thickness D on iron or steel: Measurement deviation ≥ 10 % for D ≤ 1 mm (D ≤ 0.039 ")				
Admissible ambient tem- perature at operation	-10 °C +40 °C (+14 °F +104 °F)				
Admissible specimen tem- perature	temporary max. +80 °C (max. +176 °F)				
Design	Dimensions	Approach and touchdown speed for auto-			
Single pole axial probe with spring-loaded measuring sys- tem Probe pole	80 mm (3.15 ")	mated measurement $v \ge 10 \text{ mm/s}$ $(v \ge 0.39 \text{ "/s})$			
 weal resistant material: PVD coated steel radius: 0.75 mm (29.53 mils) replaceable by Fischer service center 	Area for holding or clamping the probe Range of spring: 4 mm (0.16 ")	2 mm (0.079 °) ↓ ↓ ↓ ↓ ↓ ↓ ↓ ↓ ↓ ↓ ↓ ↓ ↓ ↓ ↓ ↓ ↓ ↓			
	Cable length: 1.5 m (59.06 "), other cable lengths on request ¹ Bending radius: \geq 30 mm (1.18 ")	Lift-off distance between 2 measure- ments $\ge 8 \text{ mm} (\ge 0.32 \text{ "})$			
Measuring method	Magnetic induction test method according to ISO 2178, ASTM D7091				
Probes work with following in	struments				
FGAB1.3-Fe (analog probe)	 Hand-held instruments: FERITSCOPE[®] FMP30 (can also measure the alpha martensit content) and FERITSCOPE[®] DMP30 series by using DMP-F-Probe-Adapter (1007336) Benchtop instruments (cannot measure the alpha martensit content) FISCHERSCOPE[®] MMS[®] PC and FISCHERSCOPE[®] MMS[®] PC2 with PERMASCOPE[®] F-Probe module (604-293) 				
D-F-Fe (digital probe)	FERITSCOPE® DMP30 (cannot measure the alpha martensit content)				
Scope of delivery	Probe with connecting cable, prism adapter for measurements on pipes and bars, placing ring for placing the probe easier onto the surface				
Options	 Calibration set 602-239 Single calibration standards on request Manufacturer Certificate M according to DIN 55350-18 (only in connection with measuring instrument) Support stand V12 MOT, 604-374, with motorized probe lowering device for highest repeatability; suitable probe clamp 602-370 included in support stand delivery Support stand V12 BASE, 604-420, with mechanical probe lowering device; suitable probe clamp 602-370 included in support stand delivery 				

1 Probes with special cable lengths have own part no. and probe model names (FGAB1.3Lx-Fe; x = cable length in meter). This data sheet also FE02.4 doc2023-03-16 applies to these probes. Probe D-F-Fe: max. cable length 3 m (118 "), it not allowed to use a USB connection cable to connect probe to instrument

